



新普科技股份有限公司
新世電子(常熟)有限公司
新普科技(重慶)有限公司
華普電子(常熟)有限公司

Control Number: SLEU-2009008

Rechargeable Li-ion Battery UN38.3 Test Report

Recommendations on the TRANSPORT OF DANGEROUS GOODS

(Manual of Tests and Criteria, Sixth revised edition, Amend 1)

Customer: Lenovo

Model: L18M3P72

Rating/ Mass: 11.52V, Typical Capacity 4345mAh/ 50Wh

Rated Capacity 4215mAh/ 49Wh /200 (g)

Issue date: 2020/09/25

Approved By	Checked By	Prepared By
Project Manager	Authorized Signatory	Test Engineer
		

●	SIMPLO TECHNOLOGY CO., LTD. ADD : No. 471 Pa Teh Rd, Sec 2 Hu Kou, Hsinchu Hsien, 303 Taiwan TEL: +886-3-5695920 FAX: +886-3-5695931	
	SIMPLO TECHNOLOGY (CHANGSHU) INC. ADD : No.888 Dongnan Avenue, Changshu New & Hi-Tech Industrial Development Zone, Changshu, Jiangsu, China TEL: +86-512-52302255 FAX: +86-512-52302277	
	SIMPLO TECHNOLOGY (CHONGQING) INC. ADD : No.2 Zongbao Avenue, Shapingba District, ChongQing, China TEL: +86-23-61718899 FAX: +86-23-61210488	
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Email : Test_Lab@simplo.com.tw

Website : <http://www.simplo.com.tw/>

Form No. : W11-002-B05

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1. Purpose of the Test :

To test each cell/battery is of the type proved to meet the requirements in United Nations Recommendations on the TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Sixth revised edition, Amend 1, Section 38.3.

2. Test Result :

Test results of the UN Recommendations on the Transport of Dangerous Goods

No.	Test Item	Test results
T.1	Altitude simulation	PASS
T.2	Thermal test	PASS
T.3	Vibration test	PASS
T.4	Shock test	PASS
T.5	External short circuit	PASS
T.6	Impact, Crush test	PASS
T.7	Overcharge	PASS
T.8	Forced discharge	PASS

3. Test Lab: Email : Test_Lab@simplo.com.tw Website : <http://www.simplo.com.tw/>

●	SIMPLO (Taiwan) Laboratory ADD : No. 471 Pa Teh Rd, Sec 2 Hu Kou, Hsinchu Hsien, 303 Taiwan TEL: +886-3-5695920 FAX: +886-3-5695931
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4. Product manufacturer : Email : Test_Lab@simplo.com.tw Website : <http://www.simplo.com.tw/>

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5. Test Quantity :

- 5.1 Four batteries, at first cycle, in fully charged states. (For T.1~T.5)
- 5.2 Four batteries, after 25 cycles ending in fully charged states. (For T.1~T.5)
- 5.3 Five component cells, at first cycle at 50% of the design rated capacity. (For T.6)
- 5.4 Five component cells, after 25 cycles at 50% of the design rated capacity. (For T.6)
- 5.5 Four batteries, at first cycle, in fully charged states. (For T.7)
- 5.6 Four batteries, after 25 cycles ending in fully charged states. (For T.7)
- 5.7 Ten component cells, at first cycle in fully discharge states. (For T.8)
- 5.8 Ten component cells, after 25 cycles ending in fully discharged states. (For T.8)

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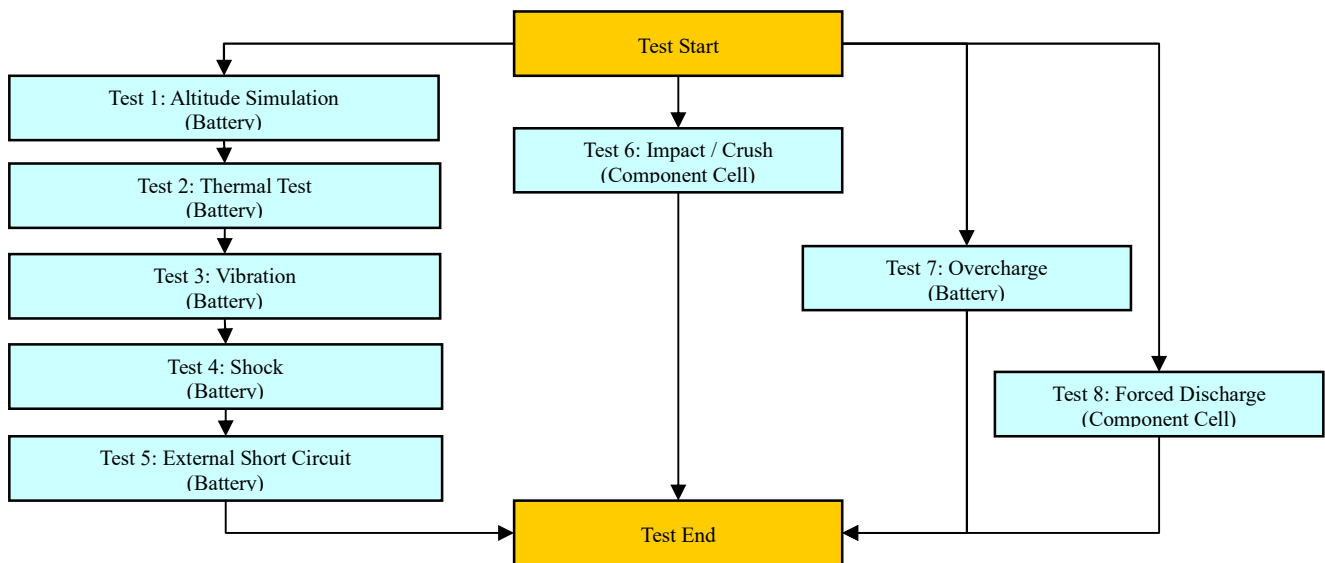
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6. Test Procedure :

6.1 All detailed test procedures must be based on United Nations Recommendations on the TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Sixth revised edition, Amend 1, Section 38.3.

6.2 Test flow shall be followed as below.



Conclusion: The samples had passed the test items of UN38.3.

7. Comment :

7.1 Follow the requirement of “TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Sixth revised edition, Amend 1, Section 38.3”, this report was updated. (The control number of old report: SLEU-1808003)

7.2 Due to the change of label, the sample picture need to modify, this report have been updated. (The control number of old report: SLEU-1808003)



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8. Test Equipment :

SMP SIMPLO TECHNOLOGY CO., LTD.

Address : No.471, Sec.2, Pa Teh Rd., Hu Kou, Hsin Chu Hsien 303, Taiwan

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Revised Date: 2018-08-16

Test Instruments Reference List								
Used	Instrument ID	Instrument Name	Type	Range of use	Manufacturer	Calibration Date_Last	Calibration Date_Next	Remarks
	Pretest							
V	ML-761	Learning	715C	0~18V 0~8A	SMP	2018/2/26	2019/2/26	
V	ML-762	Learning	715C	0~18V 0~8A	SMP	2018/1/3	2019/1/3	
V	ML-763	Learning	715C	0~18V 0~8A	SMP	2018/2/26	2019/2/26	
V	ML-764	Learning	715C	0~18V 0~8A	SMP	2018/1/3	2019/1/3	
	ML-925	Learning	750C8	0~60V 0~30A	SMP	2018/1/3	2019/1/3	
	T.1 Altitude Simulation							
V	ML-522	Altitude	SVT-120	Kpa:30~90	HSIN JIANG	2018/7/18	2019/7/18	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2018/3/1	2019/3/1	
	ML-494	Electronic Balance	XS1220M-SCS	1-1200 gf	CHUANHUA	2018/7/18	2019/7/18	
V	TD-166	Electronic Balance	PG603-S	1-610 gf	METTLER TOLEDO	2017/9/13	2018/9/13	
	ML-523	Electronic Balance	MTW-30K	30*0.005Kg		2017/9/13	2018/9/13	
V	ML-550	Data Logger	313	15~35 ℃; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	T.2 Thermal Test							
V	ML-789	Thermal Shock	GTST-080-65-AW	T:-40 to 120℃	GF	2018/1/3	2019/1/3	
V	ML-257	Multimeter	HP 34401A	note 1	Agilent	2018/3/1	2019/3/1	
	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2018/7/18	2019/7/18	
V	TD-166	Electronic Balance	PG603-S	1-610 gf	METTLER TOLEDO	2017/9/13	2018/9/13	
	ML-523	Electronic Balance	MTW-30K	30*0.005Kg		2017/9/13	2018/9/13	
V	ML-551	Data Logger	313	15~35 ℃; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	T.3 Vibration							
V	ML-233	Vibration	KD-9636-EM-300F2K-30N80	F:5~2000Hz G:0.2~20G	King Design	2017/8/29	2018/8/29	
V	ML-257	Multimeter	HP 34401A	note 1	Agilent	2018/3/1	2019/3/1	
	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2018/7/18	2019/7/18	
V	TD-166	Electronic Balance	PG603-S	1-610 gf	METTLER TOLEDO	2017/9/13	2018/9/13	
	ML-523	Electronic Balance	MTW-30K	30*0.005Kg		2017/9/13	2018/9/13	
V	ML-552	Data Logger	313	15~35 ℃; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	T.4 Shock							
V	ML-056	Shock	DP-1200-25	G:10~600G	King Design	2017/8/29	2018/8/29	
V	ML-257	Multimeter	HP 34401A	note 1	Agilent	2018/3/1	2019/3/1	
	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2018/7/18	2019/7/18	
V	TD-166	Electronic Balance	PG603-S	1-610 gf	METTLER TOLEDO	2017/9/13	2018/9/13	
	ML-523	Electronic Balance	MTW-30K	30*0.005Kg		2017/9/13	2018/9/13	
V	ML-551	Data Logger	313	15~35 ℃; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	T.5 External Short Circuit							
V	ML-534	mΩ Hitester	3540	1mΩ ~ 30kΩ	HIOKI	2017/9/18	2018/9/18	
V	ML-459	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150℃	Yokogawa	2017/9/13	2018/9/13	
V	ML-460	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150℃	Yokogawa	2017/9/13	2018/9/13	
V	ML-521	Oven	9031	30~80 ℃	YEOW LONG	2017/9/13	2018/9/13	
V	ML-549	Data Logger	313	15~35 ℃; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	T.6 Impact / Crush							
V	ML-339	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150℃	Yokogawa	2018/5/17	2019/5/17	
	ML-076	Impact Tester			JYI SHENG	2018/1/3	2019/1/3	
	ML-553	Crush Tester	BCT-01		Simplo	2018/5/16	2019/5/16	
V	ML-866	Crush Tester	M0654		JYI SHENG	2018/4/9	2019/4/9	
	ML-459	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150℃	Yokogawa	2017/9/13	2018/9/13	

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Revised Date: 2018-08-16

Test Instruments Reference List								
Used	Instrument ID	Instrument Name	Type	Range of use	Manufacturer	Calibration Date_Last	Calibration Date_Next	Remarks
	T.7 Overcharge							
	ML-482	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-483	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-484	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-486	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-487	Programmable DC Source	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2018/5/17	2019/5/17	
V	ML-549	Data Logger	313	15~35 °C; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	ML-459	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2017/9/13	2018/9/13	
	ML-460	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2017/9/13	2018/9/13	
V	ML-918	Overcharge & Forced discharge tester	T901	3~30 Vdc, Charge: 0.05~20A Discharge: 0.02~10A	SMP	2018/5/17	2019/5/17	
	T.8 Forced Discharge							
	ML-132	Electronic Load	3311C	60V,55A, 300W	Prodigit	2018/3/1	2019/3/1	
	ML-133	Electronic Load	3311C	60V,55A, 300W	Prodigit	2018/3/1	2019/3/1	
	ML-136	Electronic Load	3311C	60V,55A, 300W	Prodigit	2018/3/1	2019/3/1	
	ML-192	Electronic Load	3311C	60V,55A, 300W	Prodigit	2018/3/1	2019/3/1	
	ML-269	Electronic Load	3311C	60V,55A, 300W	Prodigit	2018/3/1	2019/3/1	
	ML-532	DC Electronic Load	33511-01	120V, 240A, 3600W	Prodigit	2018/7/18	2019/7/18	
	ML-482	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-483	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-484	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-486	Programmable DC Source	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2018/5/17	2019/5/17	
	ML-487	Programmable DC Source	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2018/5/17	2019/5/17	
V	ML-549	Data Logger	313	15~35 °C; 30~80 %RH	CENTER	2017/9/18	2018/9/18	
	ML-459	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2017/9/13	2018/9/13	
	ML-460	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2017/9/13	2018/9/13	
V	ML-918	Overcharge & Forced discharge tester	T901	3~30 Vdc, Charge: 0.05~20A Discharge: 0.02~10A	SMP	2018/5/17	2019/5/17	
Note 1: DC Voltage: 0.1-1000V; AC Voltage: 0.5-700V at 60Hz, 1kHz; Resistance: 10Ω-10MΩ; DC Current: 0.1mA-3A; AC Current: 0.01-3A at 60Hz, 0.01-1A, at 1kHz.								

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	Pretest							
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V	ML-762	Learning	715C	0~18V 0~8A	SMP	2020/1/2	2021/2/2	
V	ML-763	Learning	715C	0~18V 0~8A	SMP	2020/2/19	2021/3/19	
V	ML-764	Learning	715C	0~18V 0~8A	SMP	2020/1/2	2021/2/2	
	ML-925	Learning	750C8	0~60V 0~30A	SMP	2020/1/2	2021/2/2	
	T.6 Impact / Crush							
V	ML-458	Data Acquisition	XL122-D	1-100 Vdc, -50 to 150°C	Yokogawa	2020/6/3	2021/7/3	
	ML-076	Impact Tester			JYI SHENG	2020/1/6	2021/2/6	
	ML-553	Crush Tester	BCT-01		Simplo	2020/4/8	2021/5/8	
V	ML-866	Crush Tester	M0654		JYI SHENG	2020/4/8	2021/5/8	
	ML-459	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 200°C	Yokogawa	2020/8/11	2021/9/11	

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Control Number: SLEU-2009008

9. T.1~T.8 Detail Reports:

UN 38.3 Test Datasheet UN38.3/ST/SG/AC.10/11/Rev.6/Amend.1

Control Number: SLEU-2009008	Customer: Lenovo	Model Name: L18M3P72	SMP Project Name: Bumblebee
Pack P/N: 931QA211H (B)	Configuration: 3S1P	Test Duration: 2018/07/17~2018/08/15 2020/09/17~2020/09/24	Reviewer: Esmond
Cell Vendor: COSLIGHT	Cell Model: CA467973G-Q1	N/A	N/A

Test Sample Identification: ☐ Large Battery ☒ Small Battery ☐ Single-cell Battery

Battery Pack						Component Cell		
Used	Sample No.	Sample State	Used	Sample No.	Sample State	Used	Sample No.	Sample State
V	01~04	1 Cycle, Fully charged	V	05~08	25 Cycles, Fully charged	V	01C~05C	1 Cycle, 50% SOC
V	09~12	1 Cycle, Fully charged	V	13~16	25 Cycles, Fully charged	V	06C~10C	25 Cycles, 50% SOC
						V	11C~20C	1 Cycle, Fully discharged (0% SOC)
						V	21C~30C	25 Cycles, Fully discharged (0% SOC)

T.1 Altitude Simulation

Start time: 2018/08/01 08:40	Ambient temp.: 23.6 °C								Operator: Rasner
Finish time: 2018/08/01 15:00	Sample 01	Sample 02	Sample 03	Sample 04	Sample 05	Sample 06	Sample 07	Sample 08	
OCV (V)	Before	13.066	13.069	13.063	13.070	13.064	13.068	13.071	13.065
	After	13.051	13.054	13.048	13.056	13.050	13.054	13.057	13.051
	Residual OCV %	99.89%	99.89%	99.89%	99.89%	99.89%	99.89%	99.89%	99.89%
Mass (g)	Before	200.311	199.748	199.662	199.840	200.147	200.258	199.625	199.582
	After	200.311	199.744	199.657	199.839	200.147	200.258	199.622	199.582
	Mass loss %	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%
Results	P	P	P	P	P	P	P	P	P

T.2 Thermal Test

Start time: 2018/08/01 15:20	Ambient temp.: 24.8 °C								Operator: Rasner
Finish time: 2018/08/08 08:40	Sample 01	Sample 02	Sample 03	Sample 04	Sample 05	Sample 06	Sample 07	Sample 08	
OCV (V)	Before	13.051	13.054	13.048	13.056	13.050	13.054	13.057	13.051
	After	12.866	12.878	12.870	12.872	12.873	12.867	12.878	12.865
	Residual OCV %	98.58%	98.65%	98.64%	98.59%	98.64%	98.57%	98.63%	98.57%
Mass (g)	Before	200.311	199.744	199.657	199.839	200.147	200.258	199.622	199.582
	After	200.295	199.720	199.635	199.815	200.127	200.232	199.598	199.556
	Mass loss %	0.01%	0.01%	0.01%	0.01%	0.01%	0.01%	0.01%	0.01%
Results	P	P	P	P	P	P	P	P	P

T.3 Vibration

Start time: 2018/08/08 09:00	Ambient temp.: 23.6 °C								Operator: Rasner
Finish time: 2018/08/09 08:30	Sample 01	Sample 02	Sample 03	Sample 04	Sample 05	Sample 06	Sample 07	Sample 08	
OCV (V)	Before	12.866	12.878	12.870	12.872	12.873	12.867	12.878	12.865
	After	12.838	12.849	12.841	12.843	12.845	12.839	12.849	12.836
	Residual OCV %	99.78%	99.77%	99.77%	99.77%	99.78%	99.78%	99.77%	99.77%
Mass (g)	Before	200.295	199.720	199.635	199.815	200.127	200.232	199.598	199.556
	After	200.291	199.718	199.629	199.815	200.127	200.232	199.594	199.556
	Mass loss %	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%
Results	P	P	P	P	P	P	P	P	P

T.4 Shock

Start time: 2018/08/09 08:50	Ambient temp.: 24.4 °C								Operator: Rasner
Finish time: 2018/08/09 10:50	Sample 01	Sample 02	Sample 03	Sample 04	Sample 05	Sample 06	Sample 07	Sample 08	
OCV (V)	Before	12.838	12.849	12.841	12.843	12.845	12.839	12.849	12.836
	After	12.836	12.848	12.840	12.842	12.843	12.838	12.848	12.835
	Residual OCV %	99.98%	99.99%	99.99%	99.99%	99.98%	99.99%	99.99%	99.99%
Mass (g)	Before	200.291	199.718	199.629	199.815	200.127	200.232	199.594	199.556
	After	200.291	199.716	199.629	199.815	200.124	200.232	199.594	199.556
	Mass loss %	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%	0.00%
Results	P	P	P	P	P	P	P	P	P

Form No. : W11-002-B05

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Control Number: SLEU-2009008

T.5 External Short Circuit

Start time: 2018/08/09 11:10		Ambient temp.: 23.7 °C						Operator: Rasner	
Finish time: 2018/08/10 08:50		Sample 01	Sample 02	Sample 03	Sample 04	Sample 05	Sample 06	Sample 07	Sample 08
OCV (V)	Before	12.836	12.848	12.840	12.842	12.843	12.838	12.848	12.835
	After	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000
Resistance (<100mΩ)		59.3	62.2	56.4	58.4	60.5	57.4	56.3	61.1
Max Temp. (< 170°C)		57.5	57.5	57.2	57.4	57.3	57.5	57.4	57.5
Results		P	P	P	P	P	P	P	P

T.6 Impact / Crush (Component Cell)

UN38.3/ST/SG/AC.10/11/Rev.6/Amend.1

☐ Impact - Cylindrical cells not less than 18.0 mm in diameter

☒ Crush - Prismatic, pouch, coin/button cells and cylindrical cells less than 18.0 mm in diameter

Start time: 2020/09/24 13:03		Ambient temp.: 24.8 °C				Operator: Rasner	
Finish time: 2020/09/24 17:20		Sample 01C	Sample 02C	Sample 03C	Sample 04C	Sample 05C	
Initial OCV (V)		3.796	3.791	3.803	3.808	3.795	
Max Temp. (< 170°C)		23.6	24.3	23.8	24.5	24.0	
Results		P	P	P	P	P	
Sample No.		Sample 06C	Sample 07C	Sample 08C	Sample 09C	Sample 10C	
Initial OCV (V)		3.799	3.805	3.807	3.794	3.802	
Max Temp. (< 170°C)		23.4	23.9	24.6	24.0	23.5	
Results		P	P	P	P	P	

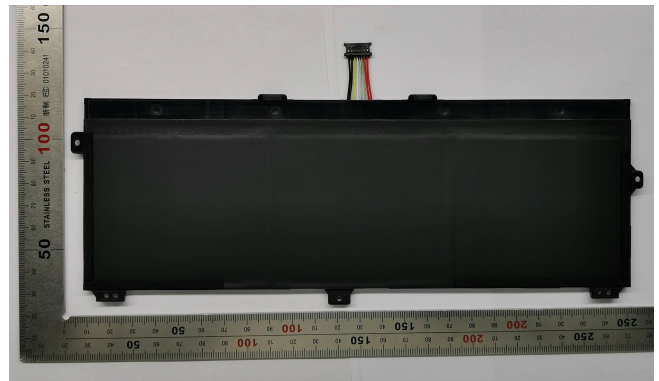
T.7 Overcharge

Start time: 2018/08/07 09:50		Ambient temp.: 23.7 °C						Operator: Rasner	
Finish time: 2018/08/15 11:00		Sample 09	Sample 10	Sample 11	Sample 12	Sample 13	Sample 14	Sample 15	Sample 16
Initial OCV (V)		13.064	13.067	13.060	13.064	13.060	13.064	13.069	13.062
Results		P	P	P	P	P	P	P	P

T.8 Forced Discharge (Component Cell)

Start time: 2018/08/06 09:30		Ambient temp.: 23.8 °C						Operator: Rasner	
Finish time: 2018/08/14 08:40		Sample 11C	Sample 12C	Sample 13C	Sample 14C	Sample 15C	Sample 16C	Sample 17C	Sample 18C
Initial OCV (V)		3.452	3.433	3.435	3.448	3.461	3.454	3.438	3.455
Results		P	P	P	P	P	P	P	P
Sample No.		Sample 19C	Sample 20C	Sample 21C	Sample 22C	Sample 23C	Sample 24C	Sample 25C	Sample 26C
Initial OCV (V)		3.448	3.459	3.447	3.462	3.458	3.453	3.440	3.446
Results		P	P	P	P	P	P	P	P
Sample No.		Sample 27C	Sample 28C	Sample 29C	Sample 30C				
Initial OCV (V)		3.457	3.450	3.442	3.447				
Results		P	P	P	P				

9. Test Sample:



Form No. : W11-002-B05

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